

Abstract Submitted
for the DAMOP19 Meeting of
The American Physical Society

Progress toward a chip-scale MOT¹ KAITLIN MOORE, NIST Boulder, JAMES MCGILLIGAN, 1) University of Colorado 2) NIST Boulder, RODOLPHE BOUDOT, 1) FEMTO-ST, CNRS, France 2) NIST Boulder, JOHN KITCHING, NIST Boulder — We report on progress toward forming a magneto-optical trap (MOT) in a passively-pumped, chip-scale MEMS-fabricable package. This work is an essential step in integrating cold atoms into mass-producible, portable instruments^{2,3}. One major challenge is preserving ultra-high vacuum levels in anodically-bonded MEMS cells without the use of an active pump. Ultra-high vacuum levels are critical to forming a vapor-loaded MOT^{4,5} and attaining commercially-relevant cell lifetimes. Here, we report on experimentally-tested solutions to mitigating gas evolution in the 1-cc-volume MEMS cell during and after the fabrication process, as well as controlling rubidium-vapor content. We report on testing performed in our actively-pumped MEMS-cell MOT systems and outline remaining steps toward achieving a true chip-scale MOT.

¹JPM gratefully acknowledges funding through a Lindemann Fellowship from the English Speaking Union. RB is supported by Delegation Generale de l'Armement and NIST Guest Researcher Program.

²J Kitching, et al. **J. Phys: Conf. Ser.** 723, 1 (2016)

³JA Rushton, et al. **Rev. of Sci. Instr.** 85, 12 (2014)

⁴T Arpornthip, et al. **PRA** 85, 033420 (2012)

⁵E Cornell, et al. In *Collected Papers Of Carl Wieman*, pp. 533-584, Sec. 2.8.4, (2008)

Kaitlin Moore
National Institute of Standards and Technology Boulder

Date submitted: 01 Feb 2019

Electronic form version 1.4